



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Koyama, et al.

Art Unit : 2871

Serial No. : 09/757,778

Examiner : Tai Duong

Filed : January 9, 2001

Title : ACTIVE MATRIX LIQUID CRYSTAL DISPLAY AND METHOD OF
FABRICATING SAME

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants submit the references listed on the attached form PTO-1449.

Submitted herewith is an English translation of the following foreign language
references, or portions thereof:

Desig. ID	Source
AL	Japan 6-244103 – English Abstract: DIALOG(R) File 352: Derwent WPI (2004); Accession No. 009997897 and family to U.S. Patent No. 5,608,232 (Desig. ID “AA”)
AM	Japan 6-244104 – English Abstract: DIALOG(R) File 345: Inpadoc/Fam. & Legal Stat (2003); Accession No. 11970014 and family to U.S. Patent No. 5,879,977 (Desig. ID “AB”)

This statement is being filed before the receipt of a first Office action on the merits after filing of a Request for Continued Examination. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 8, 2004

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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-108002	Application No. 09/757,778
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		O I P E APR 08 2006 PATENT & TRADEMARK OFFICE		
		Applicant Koyama, et al.	Filing Date January 9, 2001	Group Art Unit 2871

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,608,232	03/04/1997	Yamazaki et al.			06/05/1995
	AB	5,879,977	03/09/1999	Zhang et al.			04/23/1996
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes <input type="checkbox"/> No <input checked="" type="checkbox"/>
	AL	6-244103	09/02/1994	JAPAN			ABS <input type="checkbox"/>
	AM	6-244104	09/02/1994	JAPAN			ABS <input type="checkbox"/>
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	